

Document Title

256Kx36 & 512Kx18-Bit Synchronous Pipelined Burst SRAM

Revision History

| <u>Rev. No.</u> | <u>History</u>  | <u>Draft Date</u> | <u>Remark</u> |
|-----------------|---|-------------------|---------------|
| 0.0             | Initial draft   | May. 07 . 1998    | Preliminary   |
| 0.1             | Modify DC characteristics( Input Leakage Current test Conditions) form $V_{DD}=V_{SS}$ to $V_{DD}$ to Max.  | June .08. 1998    | Preliminary   |
| 0.2             | Remove 119BGA Package Type.   | Aug. 20. 1998     | Preliminary   |
| 0.3             | Change DC Characteristics.<br>ISB value from 65mA to 110mA at -72<br>ISB value from 60mA to 110mA at -85<br>ISB value from 50mA to 100mA at -10<br>ISB1 value from 10mA to 30mA<br>ISB2 value from 10mA to 30mA   | Aug. 27. 1998     | Preliminary   |
| 0.4             | 1. Changed t <sub>CD</sub> from 4.0ns to 4.2ns at -85.<br>Changed t <sub>OE</sub> from 4.0ns to 4.2ns at -85.<br>2. Changed DC condition at I <sub>CC</sub> and parameters<br>I <sub>CC</sub> ; from 375mA to 400mA at -72,<br>from 340mA to 380mA at -85,<br>from 300mA to 350mA at -10,<br>ISB ; from 110mA to 130mA at -72,<br>from 110mA to 130mA at -85,<br>from 100mA to 120mA at -10 | Sep. 09. 1998     | Preliminary   |
| 0.5             | Add V <sub>DDQ</sub> Supply voltage( 2.5V )   | Dec. 10. 1998     | Preliminary   |
| 0.6             | Changed V <sub>OL</sub> Max value from 0.2V to 0.4V at 2.5V I/O.  | Dec. 23. 1998     | Preliminary   |
| 1.0             | Final spec Release.   | Jan. 29. 1999     | Final         |
| 2.0             | 1. Remove V <sub>DDQ</sub> Supply voltage( 2.5V I/O )   | Feb. 25. 1999     | Final         |
| 3.0             | 1. Add V <sub>DDQ</sub> Supply voltage( 2.5V I/O )  | May. 13. 1999     | Final         |

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ELECTRONICS

**256Kx36 & 512Kx18-Bit Synchronous Pipelined Burst SRAM**

**FEATURES**

- Synchronous Operation.
- 2 Stage Pipelined operation with 4 Burst.
- On-Chip Address Counter.
- Self-Timed Write Cycle.
- On-Chip Address and Control Registers.
- 3.3V+0.165V/-0.165V Power Supply.
- I/O Supply Voltage 3.3V+0.165V/-0.165V for 3.3V I/O or 2.5V+0.4V/-0.125V for 2.5V I/O
- 5V Tolerant Inputs Except I/O Pins.
- Byte Writable Function.
- Global Write Enable Controls a full bus-width write.
- Power Down State via ZZ Signal.
- $\overline{\text{LBO}}$  Pin allows a choice of either a interleaved burst or a linear burst.
- Three Chip Enables for simple depth expansion with No Data Contention only for TQFP ; 2cycle Enable, 2cycle Disable.
- Asynchronous Output Enable Control.
- $\overline{\text{ADSP}}$ ,  $\overline{\text{ADSC}}$ ,  $\overline{\text{ADV}}$  Burst Control Pins.
- TTL-Level Three-State Output.
- 100-TQFP-1420A Package

**FAST ACCESS TIMES**

| PARAMETER                 | Symbol          | -14 | -11 | -10 | Unit |
|---------------------------|-----------------|-----|-----|-----|------|
| Cycle Time                | t <sub>cy</sub> | 7.2 | 8.5 | 10  | ns   |
| Clock Access Time         | t <sub>cd</sub> | 4.0 | 4.2 | 4.5 | ns   |
| Output Enable Access Time | t <sub>oe</sub> | 4.0 | 4.2 | 4.5 | ns   |

**GENERAL DESCRIPTION**

The K7A803601M and K7A801801M are 9,437,184-bit Synchronous Static Random Access Memory designed for high performance second level cache of Pentium and Power PC based System.

It is organized as 256K(512K) words of 36(18) bits and integrates address and control registers, a 2-bit burst address counter and added some new functions for high performance cache RAM applications;  $\overline{\text{GW}}$ ,  $\overline{\text{BW}}$ ,  $\overline{\text{LBO}}$ ,  $\overline{\text{ZZ}}$ . Write cycles are internally self-timed and synchronous.

Full bus-width write is done by  $\overline{\text{GW}}$ , and each byte write is performed by the combination of  $\overline{\text{WEx}}$  and  $\overline{\text{BW}}$  when  $\overline{\text{GW}}$  is high. And with  $\overline{\text{CS}}_1$  high,  $\overline{\text{ADSP}}$  is blocked to control signals.

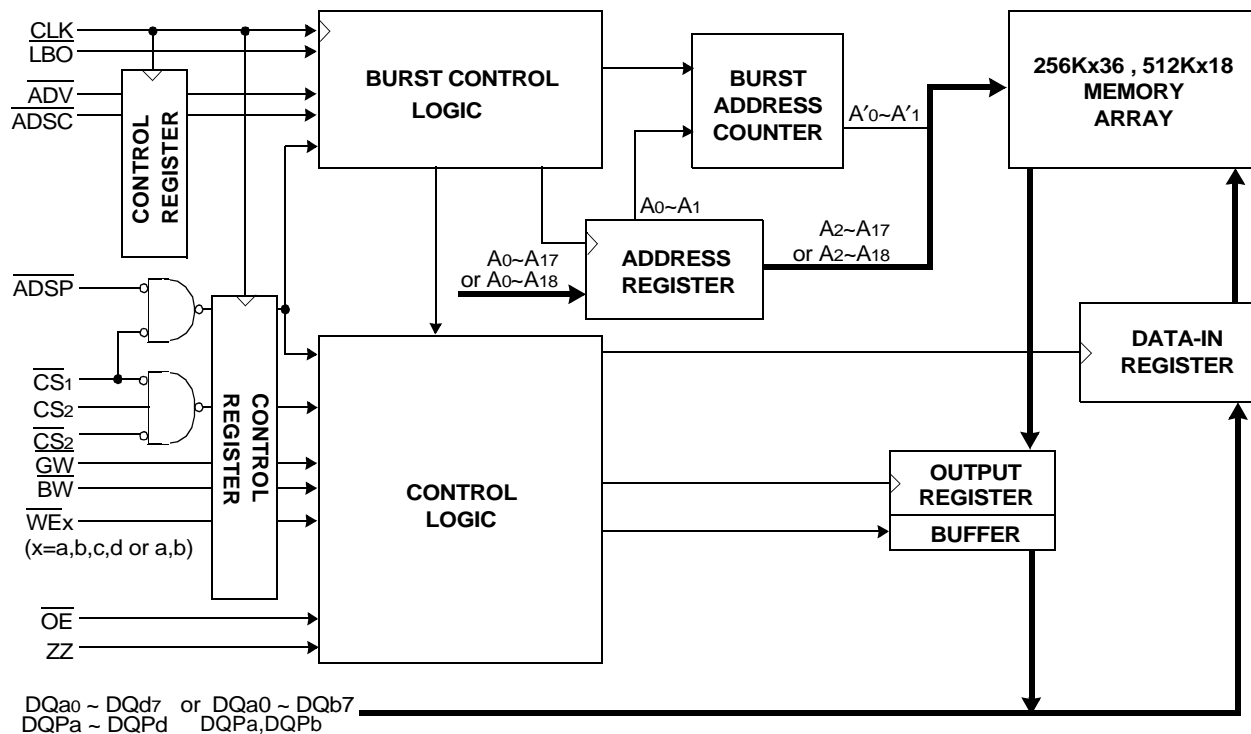
Burst cycle can be initiated with either the address status processor( $\overline{\text{ADSP}}$ ) or address status cache controller( $\overline{\text{ADSC}}$ ) inputs. Subsequent burst addresses are generated internally in the system's burst sequence and are controlled by the burst address advance( $\overline{\text{ADV}}$ ) input.

$\overline{\text{LBO}}$  pin is DC operated and determines burst sequence(linear or interleaved).

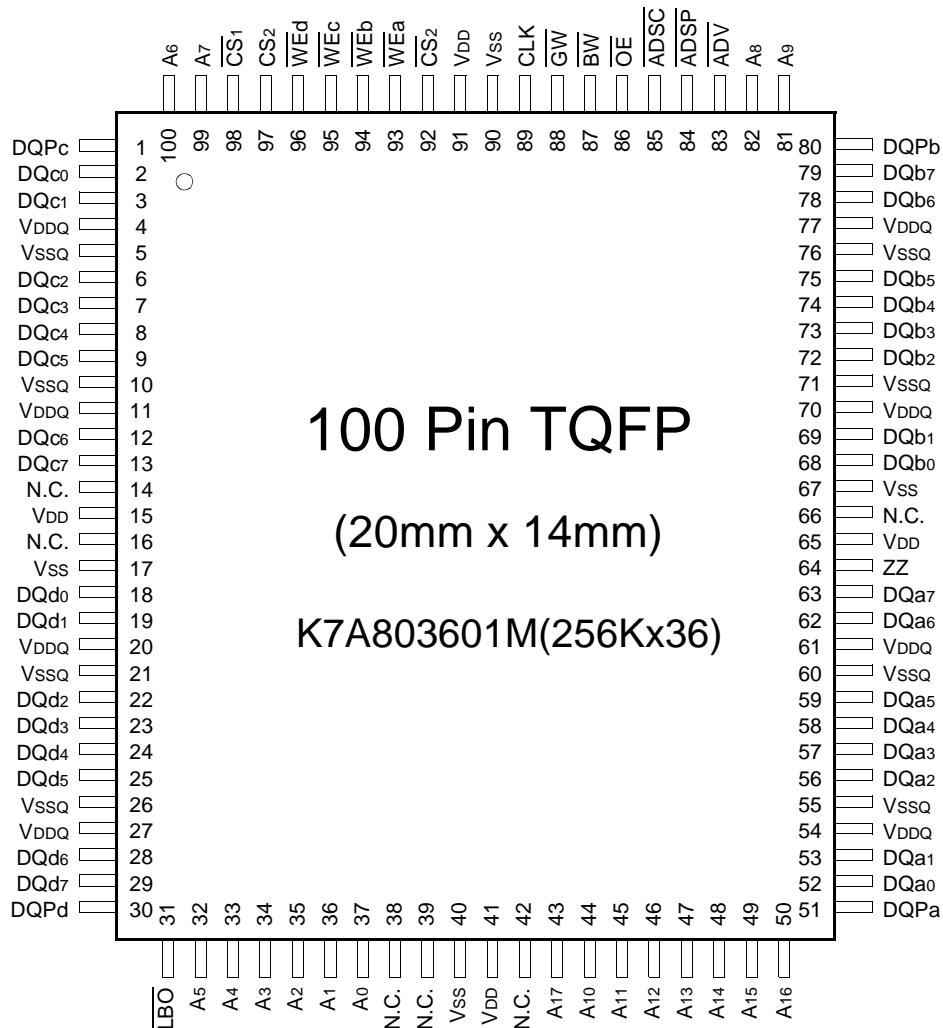
$\overline{\text{ZZ}}$  pin controls Power Down State and reduces Stand-by current regardless of CLK.

The K7A803601M and K7A801801M are fabricated using SAMSUNG's high performance CMOS technology and is available in a 100pin TQFP package. Multiple power and ground pins are utilized to minimize ground bounce.

**LOGIC BLOCK DIAGRAM**



**PIN CONFIGURATION(TOP VIEW)**



**PIN NAME**

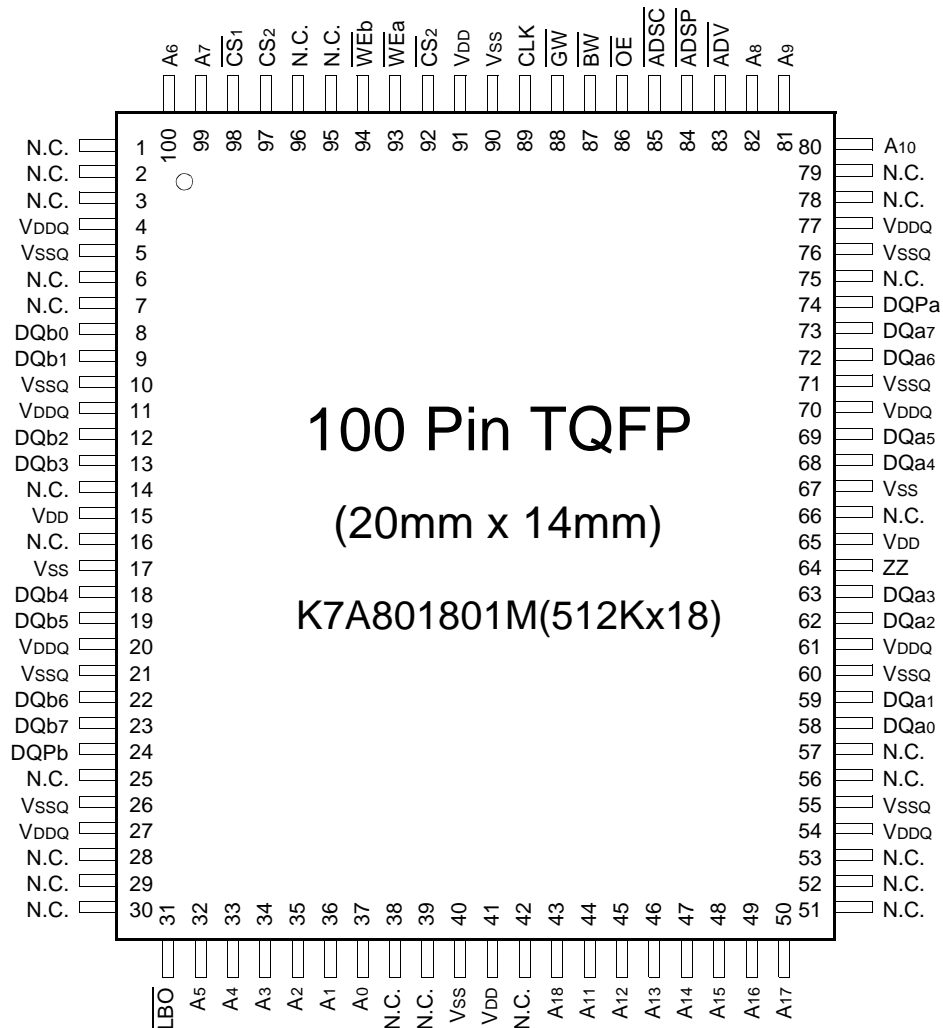
| SYMBOL                                       | PIN NAME                  | TQFP PIN NO.   | SYMBOL  | PIN NAME                              | TQFP PIN NO.            |
|--|---------------------------|--|---------|---------------------------------------|-------------------------|
| A0 - A17                                     | Address Inputs            | 32,33,34,35,36,37,43<br>44,45,46,47,48,49,50<br>81,82,99,100 | VDD     | Power Supply(+3.3V)                   | 15,41,65,91             |
|  |                           |  | VSS     | Ground                                | 17,40,67,90             |
|  |                           |  | N.C.    | No Connect                            | 14,16,38,39,42,66       |
| $\overline{\text{ADV}}$                      | Burst Address Advance     | 83   | DQa0~a7 | Data Inputs/Outputs                   | 52,53,56,57,58,59,62,63 |
| $\overline{\text{ADSP}}$                     | Address Status Processor  | 84   | DQb0~b7 |                                       | 68,69,72,73,74,75,78,79 |
| $\overline{\text{ADSC}}$                     | Address Status Controller | 85   | DQc0~c7 |                                       | 2,3,6,7,8,9,12,13       |
| CLK  | Clock                     | 89   | DQd0~d7 |                                       | 18,19,22,23,24,25,28,29 |
| CS1  | Chip Select               | 98   | DQPa~Pd |                                       | 51,80,1,30              |
| CS2  | Chip Select               | 97   | VDDQ    | Output Power Supply<br>(2.5V or 3.3V) | 4,11,20,27,54,61,70,77  |
| CS2  | Chip Select               | 92   | VSSQ    | Output Ground                         | 5,10,21,26,55,60,71,76  |
| $\overline{\text{WE}}_{\text{x(x=a,b,c,d)}}$ | Byte Write Inputs         | 93,94,95,96  |         |                                       |                         |
| OE   | Output Enable             | 86   |         |                                       |                         |
| GW   | Global Write Enable       | 88   |         |                                       |                         |
| BW   | Byte Write Enable         | 87   |         |                                       |                         |
| ZZ   | Power Down Input          | 64   |         |                                       |                         |
| LBO  | Burst Mode Control        | 31   |         |                                       |                         |

**Note :** 1. A0 and A1 are the two least significant bits(LSB) of the address field and set the internal burst counter if burst is desired.  
2. The pin 42 is reserved for address bit for the 16Mb .

# K7A803601M K7A801801M

## 256Kx36 & 512Kx18 Synchronous SRAM

### PIN CONFIGURATION(TOP VIEW)



### PIN NAME

| SYMBOL   | PIN NAME                  | TQFP PIN NO.  | SYMBOL    | PIN NAME                              | TQFP PIN NO.  |
|----------|---------------------------|---|-----------|---------------------------------------|---|
| A0 - A18 | Address Inputs            | 32,33,34,35,36,37,43<br>44,45,46,47,48,49,50<br>80,81,82,99,100 | VDD       | Power Supply(+3.3V)                   | 15,41,65,91   |
|          |                           |   | VSS       | Ground                                | 17,40,67,90   |
|          |                           |   | N.C.      | No Connect                            | 1,2,3,6,7,14,16,25,28,29,<br>30,38,39,42,51,52,53,56,<br>57,66,75,78,79,95,96 |
| ADV      | Burst Address Advance     | 83  | DQa0 ~ a7 | Data Inputs/Outputs                   | 58,59,62,63,68,69,72,73   |
| ADSP     | Address Status Processor  | 84  | DQb0 ~ b7 |                                       | 8,9,12,13,18,19,22,23   |
| ADSC     | Address Status Controller | 85  | DQPa, Pb  |                                       | 74,24   |
| CLK      | Clock                     | 89  | VDDQ      | Output Power Supply<br>(2.5V or 3.3V) | 4,11,20,27,54,61,70,77  |
| CS1      | Chip Select               | 98  | VSSQ      | Output Ground                         | 5,10,21,26,55,60,71,76  |
| CS2      | Chip Select               | 97  |           |                                       |   |
| CS2      | Chip Select               | 92  |           |                                       |   |
| WEx      | Byte Write Inputs         | 93,94   |           |                                       |   |
| OE       | Output Enable             | 86  |           |                                       |   |
| GW       | Global Write Enable       | 88  |           |                                       |   |
| BW       | Byte Write Enable         | 87  |           |                                       |   |
| ZZ       | Power Down Input          | 64  |           |                                       |   |
| LBO      | Burst Mode Control        | 31  |           |                                       |   |

**Note :** 1. A0 and A1 are the two least significant bits(LSB) of the address field and set the internal burst counter if burst is desired.  
2. The pin 42 is reserved for address bit for the 16Mb .



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**FUNCTION DESCRIPTION**

The K7A803601M and K7A801801M are synchronous SRAM designed to support the burst address accessing sequence of the Power PC based microprocessor. All inputs (with the exception of OE, LBO and ZZ) are sampled on rising clock edges. The start and duration of the burst access is controlled by ADSC, ADSP and ADV and chip select pins.

The accesses are enabled with the chip select signals and output enabled signals. Wait states are inserted into the access with ADV. When ZZ is pulled high, the SRAM will enter a Power Down State. At this time, internal state of the SRAM is preserved. When ZZ returns to low, the SRAM normally operates after 2cycles of wake up time. ZZ pin is pulled down internally.

Read cycles are initiated with ADSP (regardless of WEx and ADSC) using the new external address clocked into the on-chip address register whenever ADSP is sampled low, the chip selects are sampled active, and the output buffer is enabled with OE. In read operation the data of cell array accessed by the current address, registered in the Data-out registers by the positive edge of CLK, are carried to the Data-out buffer by the next positive edge of CLK. The data, registered in the Data-out buffer, are projected to the output pins. ADV is ignored on the clock edge that samples ADSP asserted, but is sampled on the subsequent clock edges. The address increases internally for the next access of the burst when WEx are sampled High and ADV is sampled low. And ADSP is blocked to control signals by disabling CS1.

All byte write is done by GW (regardless of BW and WEx.), and each byte write is performed by the combination of BW and WEx when GW is high.

Write cycles are performed by disabling the output buffers with OE and asserting WEx. WEx are ignored on the clock edge that samples ADSP low, but are sampled on the subsequent clock edges. The output buffers are disabled when WEx are sampled Low (regardless of OE). Data is clocked into the data input register when WEx sampled Low. The address increases internally to the next address of burst, if both WEx and ADV are sampled Low. Individual byte write cycles are performed by any one or more byte write enable signals (WEa, WEb, WEc or WEd) sampled low. The WEa control DQa0 ~ DQa7 and DQPa, WEb controls DQb0 ~ DQb7 and DQPb, WEc controls DQc0 ~ DQc7 and DQPc, and WEd control DQd0 ~ DQd7 and DQPd. Read or write cycle may also be initiated with ADSC, instead of ADSP. The differences between cycles initiated with ADSC and ADSP as are follows;

ADSP must be sampled high when ADSC is sampled low to initiate a cycle with ADSC.

WEx are sampled on the same clock edge that sampled ADSC low (and ADSP high).

Addresses are generated for the burst access as shown below, The starting point of the burst sequence is provided by the external address. The burst address counter wraps around to its initial state upon completion. The burst sequence is determined by the state of the LBO pin. When this pin is Low, linear burst sequence is selected. When this pin is High, Interleaved burst sequence is selected.

**BURST SEQUENCE TABLE**

(Interleaved Burst)

| LBO PIN | HIGH           | Case 1 |    | Case 2 |    | Case 3 |    | Case 4 |    |
|---------|----------------|--------|----|--------|----|--------|----|--------|----|
|         |                | A1     | A0 | A1     | A0 | A1     | A0 | A1     | A0 |
|         | First Address  | 0      | 0  | 0      | 1  | 1      | 0  | 1      | 1  |
|         | ↓              | 0      | 1  | 0      | 0  | 1      | 1  | 1      | 0  |
|         | ↓              | 1      | 0  | 1      | 1  | 0      | 0  | 0      | 1  |
|         | Fourth Address | 1      | 1  | 1      | 0  | 0      | 1  | 0      | 0  |

(Linear Burst)

| LBO PIN | LOW            | Case 1 |    | Case 2 |    | Case 3 |    | Case 4 |    |
|---------|----------------|--------|----|--------|----|--------|----|--------|----|
|         |                | A1     | A0 | A1     | A0 | A1     | A0 | A1     | A0 |
|         | First Address  | 0      | 0  | 0      | 1  | 1      | 0  | 1      | 1  |
|         | ↓              | 0      | 1  | 1      | 0  | 1      | 1  | 0      | 0  |
|         | ↓              | 1      | 0  | 1      | 1  | 0      | 0  | 0      | 1  |
|         | Fourth Address | 1      | 1  | 0      | 0  | 0      | 1  | 1      | 0  |

Note : 1. LBO pin must be tied to High or Low, and Floating State must not be allowed.

**ASYNCHRONOUS TRUTH TABLE**

| OPERATION  | ZZ | OE | I/O Status  |
|------------|----|----|-------------|
| Sleep Mode | H  | X  | High-Z      |
| Read       | L  | L  | DQ          |
|            | L  | H  | High-Z      |
| Write      | L  | X  | Din, High-Z |
| Deselected | L  | X  | High-Z      |

**Notes**

1. X means "Don't Care".
2. ZZ pin is pulled down internally
3. For write cycles that following read cycles, the output buffers must be disabled with OE, otherwise data bus contention will occur.
4. Sleep Mode means power down state of which stand-by current does not depend on cycle time.
5. Deselected means power down state of which stand-by current depends on cycle time.

**TRUTH TABLES**

**SYNCHRONOUS TRUTH TABLE**

| $\overline{CS}_1$ | $CS_2$ | $\overline{CS}_2$ | $\overline{ADSP}$ | $\overline{ADSC}$ | $\overline{ADV}$ | $\overline{WRITE}$ | CLK | ADDRESS ACCESSED | OPERATION                  |
|-------------------|--------|-------------------|-------------------|-------------------|------------------|--------------------|-----|------------------|----------------------------|
| H                 | X      | X                 | X                 | L                 | X                | X                  | ↑   | N/A              | Not Selected               |
| L                 | L      | X                 | L                 | X                 | X                | X                  | ↑   | N/A              | Not Selected               |
| L                 | X      | H                 | L                 | X                 | X                | X                  | ↑   | N/A              | Not Selected               |
| L                 | L      | X                 | X                 | L                 | X                | X                  | ↑   | N/A              | Not Selected               |
| L                 | X      | H                 | X                 | L                 | X                | X                  | ↑   | N/A              | Not Selected               |
| L                 | H      | L                 | L                 | X                 | X                | X                  | ↑   | External Address | Begin Burst Read Cycle     |
| L                 | H      | L                 | H                 | L                 | X                | L                  | ↑   | External Address | Begin Burst Write Cycle    |
| L                 | H      | L                 | H                 | L                 | X                | H                  | ↑   | External Address | Begin Burst Read Cycle     |
| X                 | X      | X                 | H                 | H                 | L                | H                  | ↑   | Next Address     | Continue Burst Read Cycle  |
| H                 | X      | X                 | X                 | H                 | L                | H                  | ↑   | Next Address     | Continue Burst Read Cycle  |
| X                 | X      | X                 | H                 | H                 | L                | L                  | ↑   | Next Address     | Continue Burst Write Cycle |
| H                 | X      | X                 | X                 | H                 | L                | L                  | ↑   | Next Address     | Continue Burst Write Cycle |
| X                 | X      | X                 | H                 | H                 | H                | H                  | ↑   | Current Address  | Suspend Burst Read Cycle   |
| H                 | X      | X                 | X                 | H                 | H                | H                  | ↑   | Current Address  | Suspend Burst Read Cycle   |
| X                 | X      | X                 | H                 | H                 | H                | L                  | ↑   | Current Address  | Suspend Burst Write Cycle  |
| H                 | X      | X                 | X                 | H                 | H                | L                  | ↑   | Current Address  | Suspend Burst Write Cycle  |

- Notes :** 1. X means "Don't Care". 2. The rising edge of clock is symbolized by ↑.  
 3.  $\overline{WRITE} = L$  means Write operation in WRITE TRUTH TABLE.  
 $\overline{WRITE} = H$  means Read operation in WRITE TRUTH TABLE.  
 4. Operation finally depends on status of asynchronous input pins(ZZ and  $\overline{OE}$ ).

**WRITE TRUTH TABLE(x36)**

| $\overline{GW}$ | $\overline{BW}$ | $\overline{WEa}$ | $\overline{WEb}$ | $\overline{WEc}$ | $\overline{WEd}$ | OPERATION          |
|-----------------|-----------------|------------------|------------------|------------------|------------------|--------------------|
| H               | H               | X                | X                | X                | X                | READ               |
| H               | L               | H                | H                | H                | H                | READ               |
| H               | L               | L                | H                | H                | H                | WRITE BYTE a       |
| H               | L               | H                | L                | H                | H                | WRITE BYTE b       |
| H               | L               | H                | H                | L                | L                | WRITE BYTE c and d |
| H               | L               | L                | L                | L                | L                | WRITE ALL BYTEs    |
| L               | X               | X                | X                | X                | X                | WRITE ALL BYTEs    |

- Note :** 1. X means "Don't Care".  
 2. All inputs in this table must meet setup and hold time around the rising edge of CLK(↑).

**WRITE TRUTH TABLE(x18)**

| $\overline{GW}$ | $\overline{BW}$ | $\overline{WEa}$ | $\overline{WEb}$ | OPERATION       |
|-----------------|-----------------|------------------|------------------|-----------------|
| H               | H               | X                | X                | READ            |
| H               | L               | H                | H                | READ            |
| H               | L               | L                | H                | WRITE BYTE a    |
| H               | L               | H                | L                | WRITE BYTE b    |
| H               | L               | L                | L                | WRITE ALL BYTEs |
| L               | X               | X                | X                | WRITE ALL BYTEs |

- Note :** 1. X means "Don't Care".  
 2. All inputs in this table must meet setup and hold time around the rising edge of CLK(↑).



**PASS-THROUGH TRUTH TABLE**

| PREVIOUS CYCLE                                    |       | PRESENT CYCLE  |                 |       |    | NEXT CYCLE                          |
|---|-------|--|-----------------|-------|----|-------------------------------------|
| OPERATION   | WRITE | OPERATION  | CS <sub>1</sub> | WRITE | OE |                                     |
| Write Cycle, All bytes<br>Address=An-1, Data=Dn-1 | All L | Initiate Read Cycle<br>Address=An<br>Data=Qn-1 for all bytes | L               | H     | L  | Read Cycle<br>Data=Qn               |
| Write Cycle, All bytes<br>Address=An-1, Data=Dn-1 | All L | No new cycle<br>Data=Qn-1 for all bytes                      | H               | H     | L  | No carryover from<br>previous cycle |
| Write Cycle, All bytes<br>Address=An-1, Data=Dn-1 | All L | No new cycle<br>Data=High-Z                                  | H               | H     | H  | No carryover from<br>previous cycle |
| Write Cycle, One byte<br>Address=An-1, Data=Dn-1  | One L | Initiate Read Cycle<br>Address=An<br>Data=Qn-1 for one byte  | L               | H     | L  | Read Cycle<br>Data=Qn               |
| Write Cycle, One byte<br>Address=An-1, Data=Dn-1  | One L | No new cycle<br>Data=Qn-1 for one byte                       | H               | H     | L  | No carryover from<br>previous cycle |

**Note** : 1. This operation makes written data immediately available at output during a read cycle preceded by a write cycle.

**ABSOLUTE MAXIMUM RATINGS\***

| PARAMETER                              | SYMBOL | RATING           | UNIT |
|--|--------|------------------|------|
| Voltage on VDD Supply Relative to Vss  | VDD    | -0.3 to 4.6      | V    |
| Voltage on VDDQ Supply Relative to Vss | VDDQ   | VDD              | V    |
| Voltage on Input Pin Relative to Vss   | VIN    | -0.3 to 4.6      | V    |
| Voltage on I/O Pin Relative to Vss     | VIO    | -0.3 to VDDQ+0.5 | V    |
| Power Dissipation                      | PD     | 1.6              | W    |
| Storage Temperature                    | TSTG   | -65 to 150       | °C   |
| Operating Temperature                  | TOPR   | 0 to 70          | °C   |
| Storage Temperature Range Under Bias   | TBIAS  | -10 to 85        | °C   |

**\*Note** : Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**OPERATING CONDITIONS at 3.3V I/O**(0°C ≤ TA ≤ 70°C)

| PARAMETER      | SYMBOL | MIN   | Typ. | MAX   | UNIT |
|----------------|--------|-------|------|-------|------|
| Supply Voltage | VDD    | 3.135 | 3.3  | 3.465 | V    |
|                | VDDQ   | 3.135 | 3.3  | 3.465 | V    |
| Ground         | Vss    | 0     | 0    | 0     | V    |

**OPERATING CONDITIONS at 2.5V I/O**(0°C ≤ TA ≤ 70°C)

| PARAMETER      | SYMBOL | MIN   | Typ. | MAX   | UNIT |
|----------------|--------|-------|------|-------|------|
| Supply Voltage | VDD    | 3.135 | 3.3  | 3.465 | V    |
|                | VDDQ   | 2.375 | 2.5  | 2.9   | V    |
| Ground         | Vss    | 0     | 0    | 0     | V    |

**CAPACITANCE\***(TA=25°C, f=1MHz)

| PARAMETER          | SYMBOL | TEST CONDITION | MIN | MAX | UNIT |
|--------------------|--------|----------------|-----|-----|------|
| Input Capacitance  | CIN    | VIN=0V         | -   | 6   | pF   |
| Output Capacitance | COUT   | VOUT=0V        | -   | 8   | pF   |

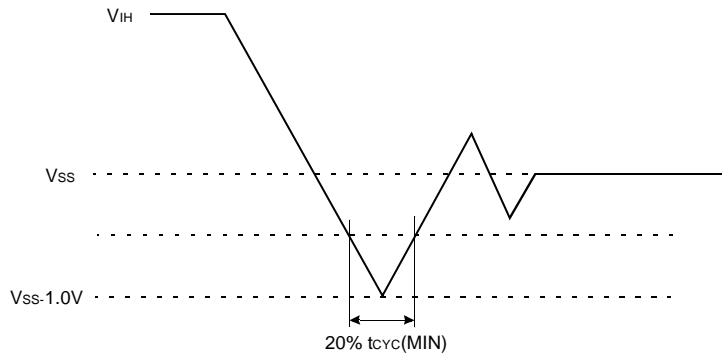
**\*Note** : Sampled not 100% tested.



**DC ELECTRICAL CHARACTERISTICS**( $V_{DD}=3.3V+0.165V/-0.165V$ ,  $T_A=0^{\circ}C$  to  $+70^{\circ}C$ )

| PARAMETER                        | SYMBOL   | TEST CONDITIONS  | MIN   | MAX               | UNIT    | NOTES |     |
|----------------------------------|--|--|-------|-------------------|---------|-------|-----|
| Input Leakage Current(except ZZ) | IIL  | $V_{DD} = \text{Max}$ ; $V_{IN} = V_{SS}$ to $V_{DD}$  | -2    | +2                | $\mu A$ |       |     |
| Output Leakage Current           | IoL  | Output Disabled, $V_{OUT} = V_{SS}$ to $V_{DDQ}$   | -2    | +2                | $\mu A$ |       |     |
| Operating Current                | Icc  | Device Selected, $I_{OUT}=0mA$ ,<br>ZZ $\leq V_{IL}$ , Cycle Time $\geq t_{CYC}$ Min                         | -14   | -                 | 400     | mA    | 1,2 |
|                                  |  |  | -11   | -                 | 380     |       |     |
|                                  |  |  | -10   | -                 | 350     |       |     |
| Standby Current                  | ISB  | Device deselected, $I_{OUT}=0mA$ ,<br>ZZ $\leq V_{IL}$ , f=Max, All Inputs $\leq 0.2V$ or $\geq V_{DD}-0.2V$ | -14   | -                 | 130     | mA    |     |
|                                  |  |  | -11   | -                 | 130     |       |     |
|                                  |  |  | -10   | -                 | 120     |       |     |
|                                  | ISB1   | Device deselected, $I_{OUT}=0mA$ , ZZ $\leq 0.2V$ ,<br>f =0, All Inputs=fixed ( $V_{DD}-0.2V$ or $0.2V$ )    | -     | 30                | mA      |       |     |
| ISB2                             | Device deselected, $I_{OUT}=0mA$ , ZZ $\geq V_{DD}-0.2V$ ,<br>f=Max, All Inputs $\leq V_{IL}$ or $\geq V_{IH}$ | -  | 30    | mA                |         |       |     |
| Output Low Voltage(3.3V I/O)     | VoL  | IoL=8.0mA  | -     | 0.4               | V       |       |     |
| Output High Voltage(3.3V I/O)    | VoH  | IoH=-4.0mA   | 2.4   | -                 | V       |       |     |
| Output Low Voltage(2.5V I/O)     | VoL  | IoL=1.0mA  | -     | 0.4               | V       |       |     |
| Output High Voltage(2.5V I/O)    | VoH  | IoH=-1.0mA   | 2.0   | -                 | V       |       |     |
| Input Low Voltage(3.3V I/O)      | VIL  |  | -0.3* | 0.8               | V       |       |     |
| Input High Voltage(3.3V I/O)     | VIH  |  | 2.0   | $V_{DD}+0.5^{**}$ | V       | 3     |     |
| Input Low Voltage(2.5V I/O)      | VIL  |  | -0.3* | 0.7               | V       |       |     |
| Input High Voltage(2.5V I/O)     | VIH  |  | 1.7   | $V_{DD}+0.5^{**}$ | V       | 3     |     |

- Notes :** 1. Reference AC Operating Conditions and Characteristics for input and timing.  
2. Data states are all zero.  
3. In Case of I/O Pins, the Max.  $V_{IH}=V_{DDQ}+0.3V$

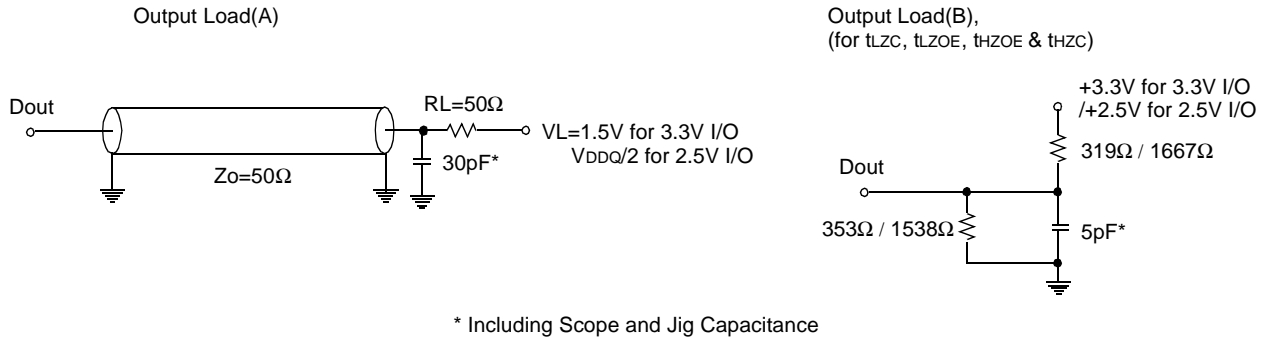


**TEST CONDITIONS**

( $V_{DD}=3.3V+0.165V/-0.165V$ ,  $V_{DDQ}=3.3V+0.165V/-0.165V$  or  $V_{DD}=3.3V+0.165V/-0.165V$ ,  $V_{DDQ}=2.5V+0.4V/-0.125V$ ,  $T_A=0$ to $70^{\circ}C$ )

| PARAMETER   | VALUE       |
|---|-------------|
| Input Pulse Level(for 3.3V I/O)                               | 0 to 3.0V   |
| Input Pulse Level(for 2.5V I/O)                               | 0 to 2.5V   |
| Input Rise and Fall Time(Measured at 20% to 80% for 3.3V I/O) | 1.0V/ns     |
| Input Rise and Fall Time(Measured at 20% to 80% for 2.5V I/O) | 1.0V/ns     |
| Input and Output Timing Reference Levels for 3.3V I/O         | 1.5V        |
| Input and Output Timing Reference Levels for 2.5V I/O         | $V_{DDQ}/2$ |
| Output Load   | See Fig. 1  |





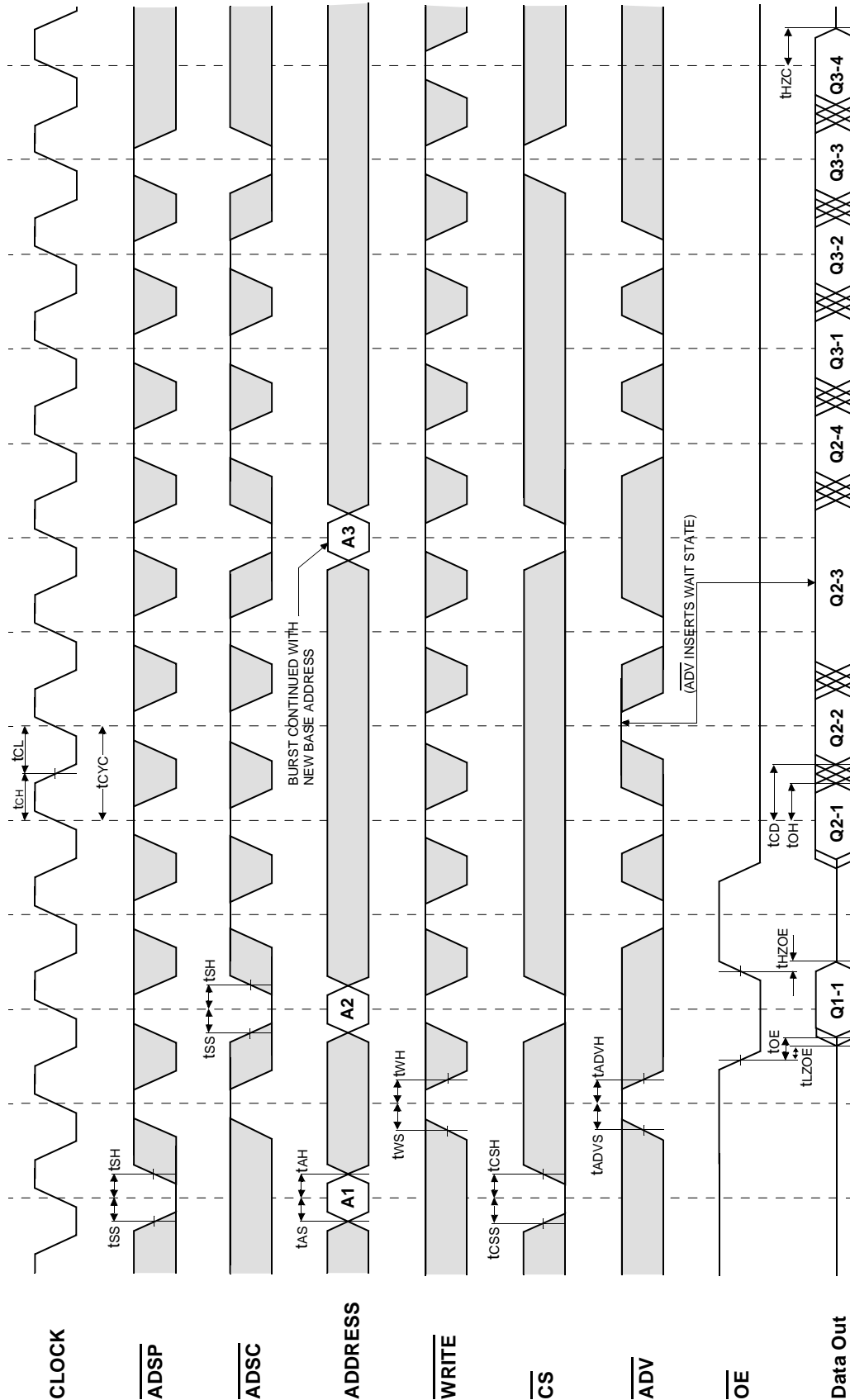
**Fig. 1**

**AC TIMING CHARACTERISTICS**( $V_{DD}=3.3V+0.165V/-0.165V$ ,  $T_A=0^{\circ}C$  to  $+70^{\circ}C$ )

| PARAMETER   | SYMBOL            | -14 |     | -11 |     | -10 |     | UNIT  |
|---|-------------------|-----|-----|-----|-----|-----|-----|-------|
|   |                   | MIN | MAX | MIN | MAX | MIN | MAX |       |
| Cycle Time  | t <sub>CYC</sub>  | 7.2 | -   | 8.5 | -   | 10  | -   | ns    |
| Clock Access Time   | t <sub>CD</sub>   | -   | 4.0 | -   | 4.2 | -   | 4.5 | ns    |
| Output Enable to Data Valid   | t <sub>OE</sub>   | -   | 4.0 | -   | 4.2 | -   | 4.5 | ns    |
| Clock High to Output Low-Z  | t <sub>LZC</sub>  | 0   | -   | 0   | -   | 0   | -   | ns    |
| Output Hold from Clock High   | t <sub>OH</sub>   | 1.5 | -   | 1.5 | -   | 1.5 | -   | ns    |
| Output Enable Low to Output Low-Z   | t <sub>LZOE</sub> | 0   | -   | 0   | -   | 0   | -   | ns    |
| Output Enable High to Output High-Z   | t <sub>HZOE</sub> | -   | 3.5 | -   | 3.5 | -   | 4.0 | ns    |
| Clock High to Output High-Z   | t <sub>HZC</sub>  | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 4.0 | ns    |
| Clock High Pulse Width  | t <sub>CH</sub>   | 2.5 | -   | 2.5 | -   | 3.0 | -   | ns    |
| Clock Low Pulse Width   | t <sub>CL</sub>   | 2.5 | -   | 2.5 | -   | 3.0 | -   | ns    |
| Address Setup to Clock High   | t <sub>AS</sub>   | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Address Status Setup to Clock High  | t <sub>SS</sub>   | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Data Setup to Clock High  | t <sub>DS</sub>   | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Write Setup to Clock High ( $\overline{GW}$ , $\overline{BW}$ , $\overline{WEX}$ )  | t <sub>WS</sub>   | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Address Advance Setup to Clock High   | t <sub>ADVS</sub> | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Chip Select Setup to Clock High   | t <sub>CSS</sub>  | 2.0 | -   | 2.0 | -   | 2.0 | -   | ns    |
| Address Hold from Clock High  | t <sub>AH</sub>   | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| Address Status Hold from Clock High   | t <sub>SH</sub>   | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| Data Hold from Clock High   | t <sub>DH</sub>   | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| Write Hold from Clock High ( $\overline{GW}$ , $\overline{BW}$ , $\overline{WEX}$ ) | t <sub>WH</sub>   | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| Address Advance Hold from Clock High  | t <sub>ADVH</sub> | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| Chip Select Hold from Clock High  | t <sub>CSH</sub>  | 0.5 | -   | 0.5 | -   | 0.5 | -   | ns    |
| ZZ High to Power Down   | t <sub>PD</sub>   | 2   | -   | 2   | -   | 2   | -   | cycle |
| ZZ Low to Power Up  | t <sub>PUS</sub>  | 2   | -   | 2   | -   | 2   | -   | cycle |

**Notes :** 1. All address inputs must meet the specified setup and hold times for all rising clock edges whenever  $\overline{ADSC}$  and/or  $\overline{ADSP}$  is sampled low and  $\overline{CS}$  is sampled low. All other synchronous inputs must meet the specified setup and hold times whenever this device is chip selected.  
 2. Both chip selects must be active whenever  $\overline{ADSC}$  or  $\overline{ADSP}$  is sampled low in order for the this device to remain enabled.  
 3.  $\overline{ADSC}$  or  $\overline{ADSP}$  must not be asserted for at least 2 Clock after leaving ZZ state.  
 4. At any given voltage and temperature, t<sub>HZC</sub> is less than t<sub>LZC</sub>

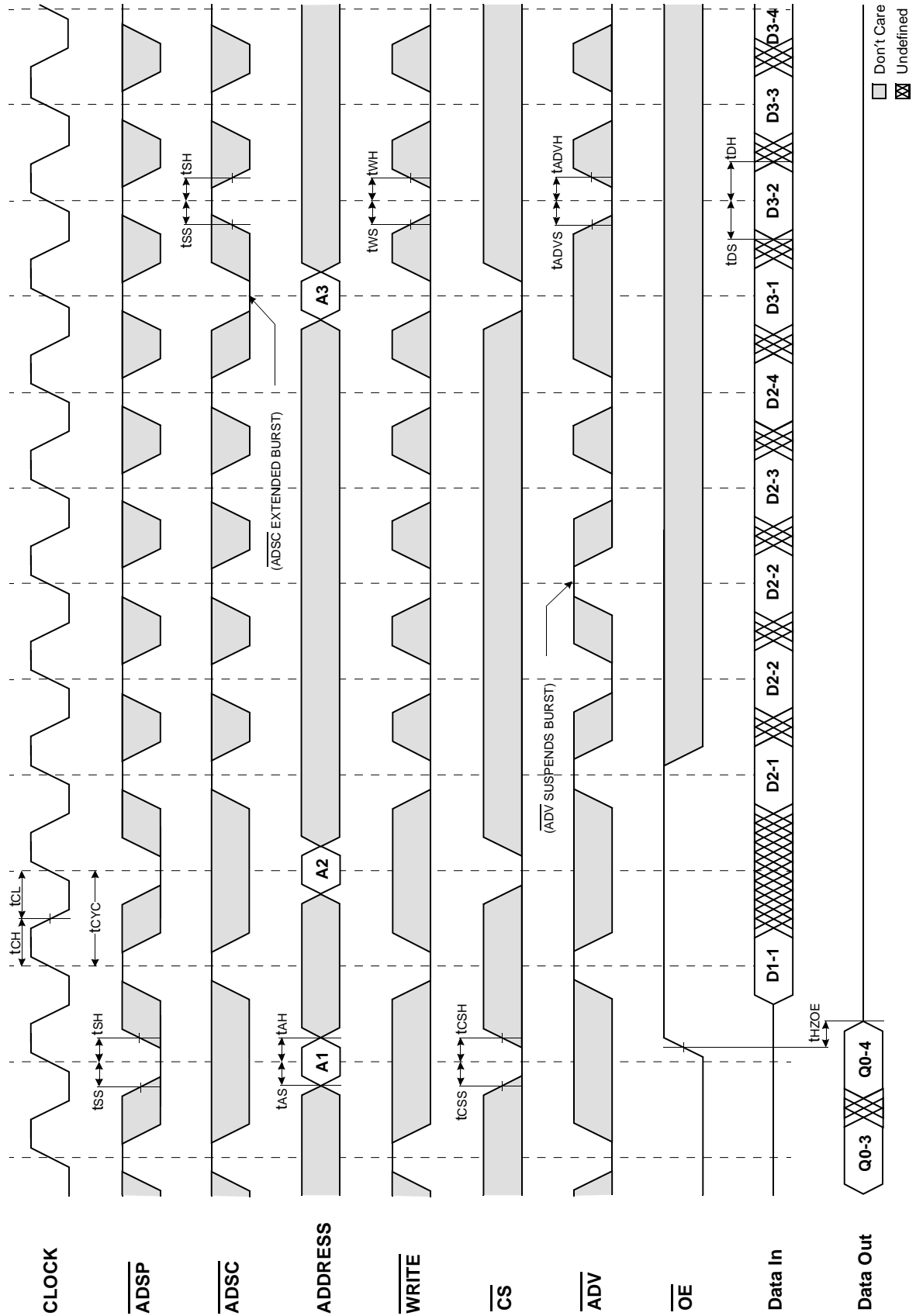
TIMING WAVEFORM OF READ CYCLE



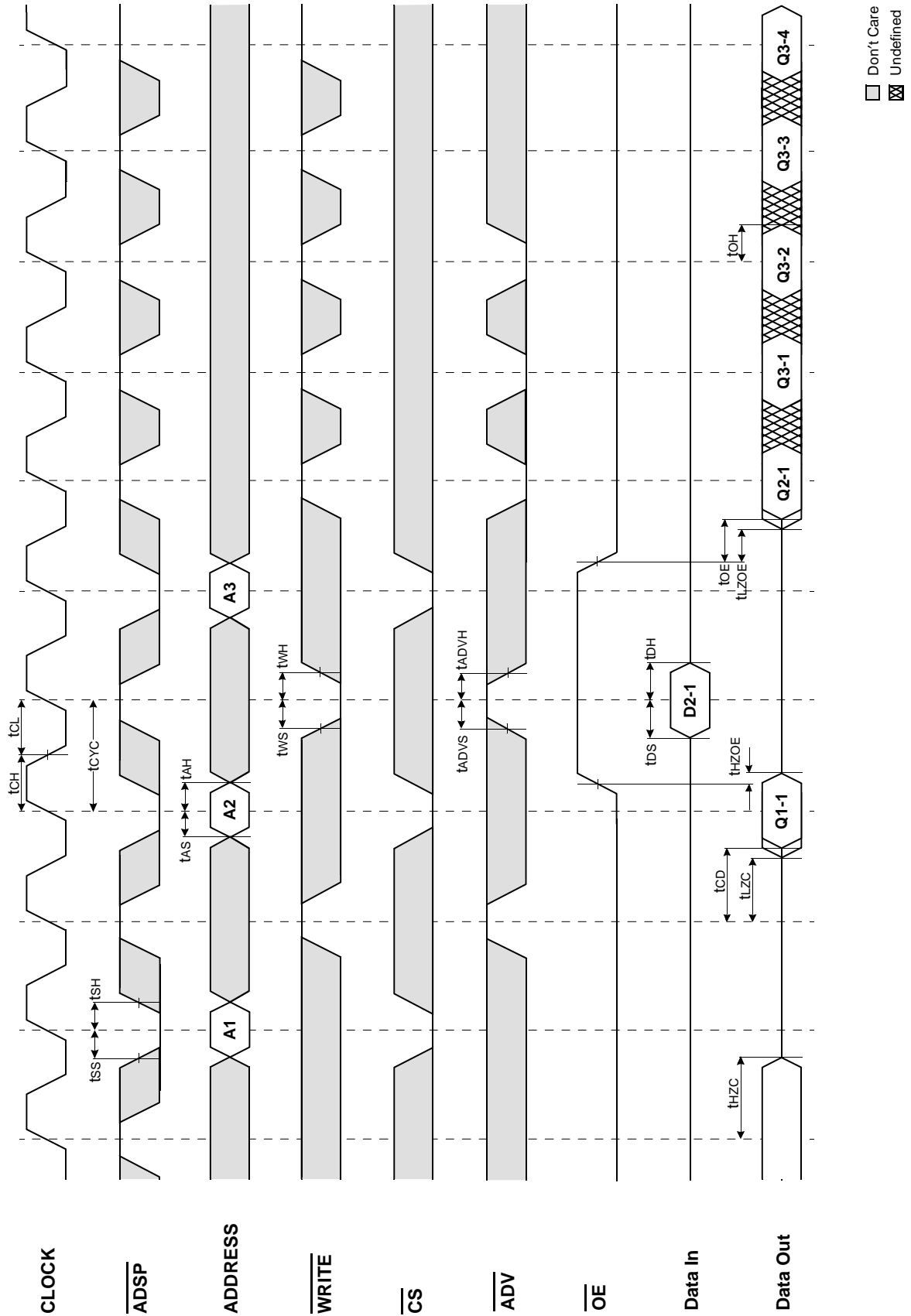
Don't Care  
 Undefined

**NOTES:**  $\overline{WRITE} = L$  means  $\overline{GW} = L$ , or  $\overline{GW} = H, \overline{BW} = L, \overline{WEX} = L$   
 $\overline{CS} = L$  means  $\overline{CS}_1 = L, \overline{CS}_2 = H$  and  $\overline{CS}_2 = L$   
 $\overline{CS} = H$  means  $\overline{CS}_1 = H$ , or  $\overline{CS}_1 = L$  and  $\overline{CS}_2 = H$ , or  $\overline{CS}_1 = L$ , and  $\overline{CS}_2 = L$

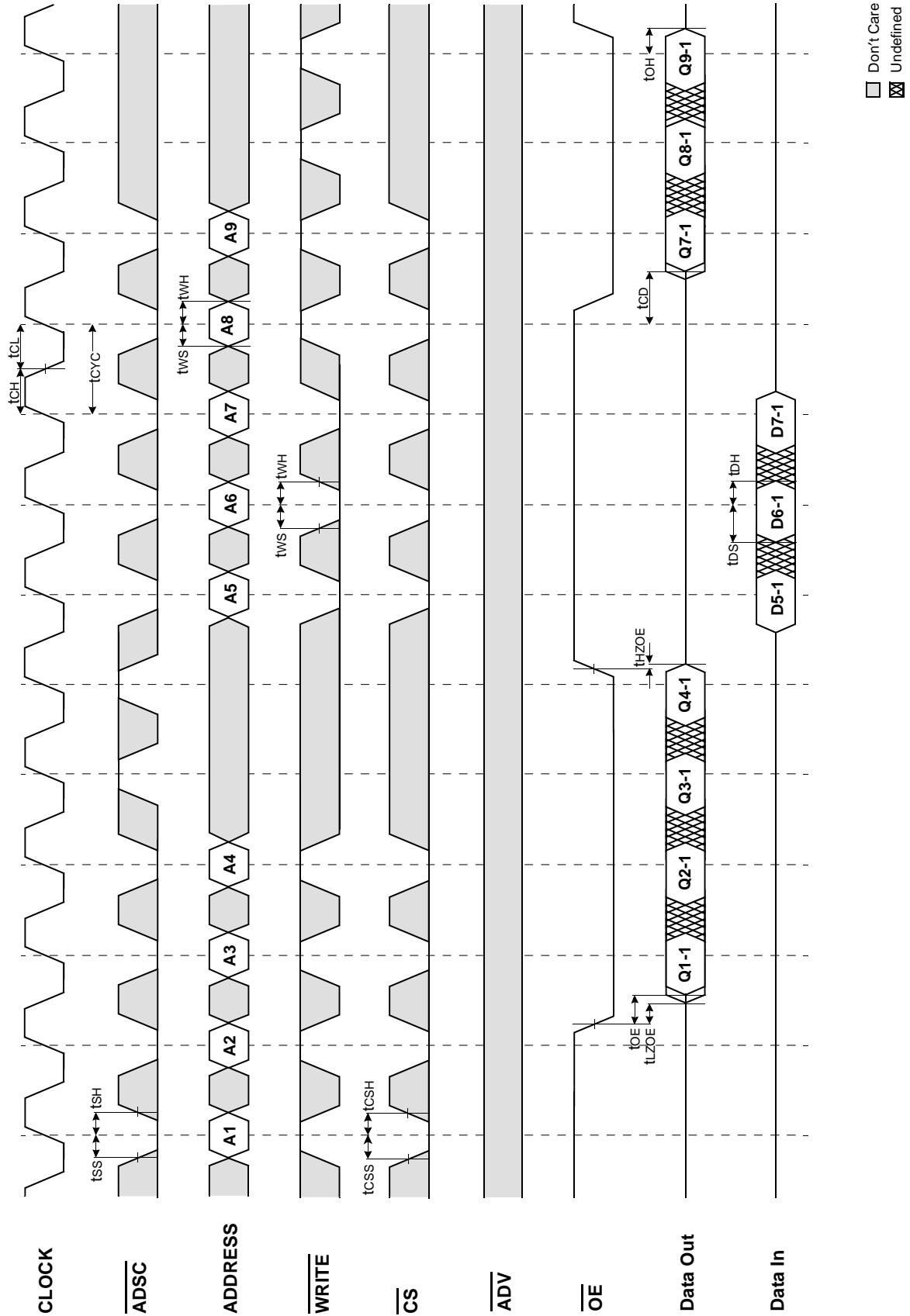
TIMING WAVEFORM OF WRTE CYCLE



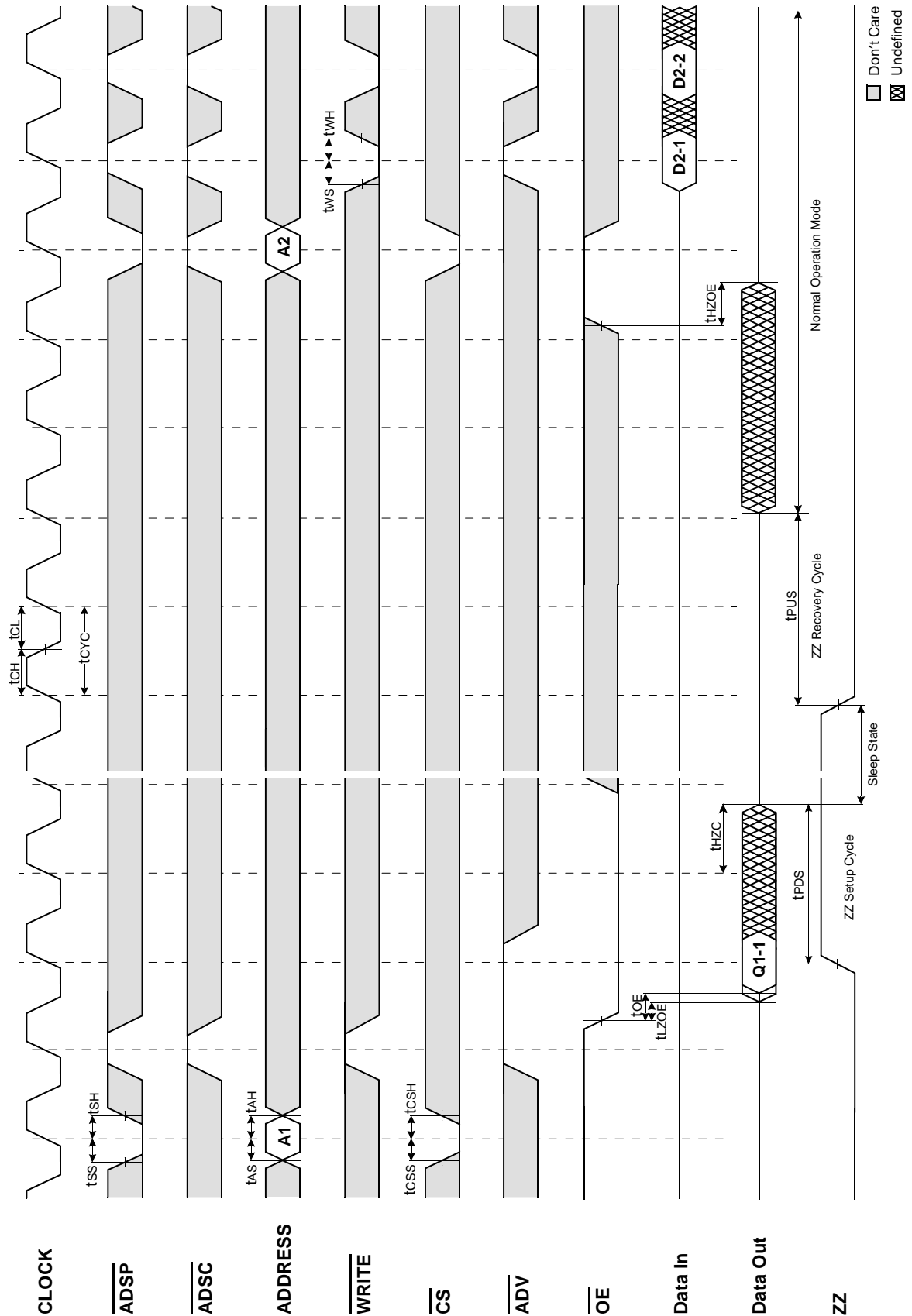
TIMING WAVEFORM OF COMBINATION READ/WRITE CYCLE(ADSP CONTROLLED,  $\overline{\text{ADSC}}=\text{HIGH}$ )



TIMING WAVEFORM OF SINGLE READ/WRITE CYCLE (ADSC CONTROLLED,  $\overline{\text{ADSP}}=\text{HIGH}$ )



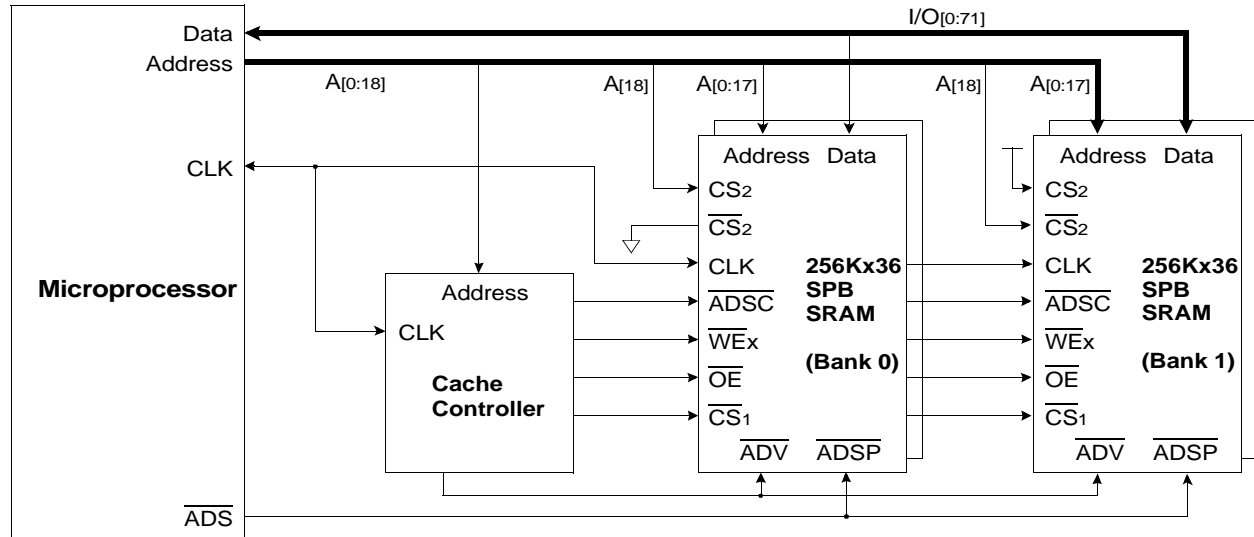
TIMING WAVEFORM OF POWER DOWN CYCLE



APPLICATION INFORMATION

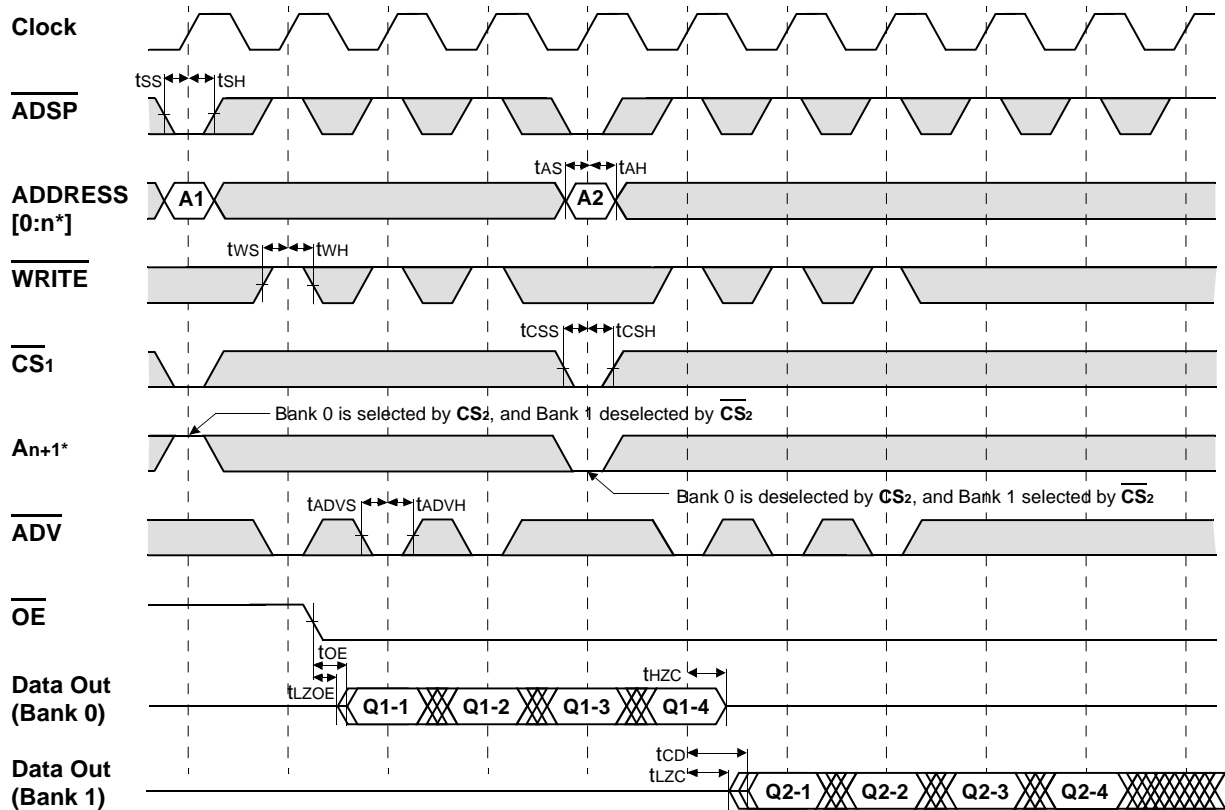
DEPTH EXPANSION

The Samsung 256Kx36 Synchronous Pipelined Burst SRAM has two additional chip selects for simple depth expansion. This permits easy secondary cache upgrades from 256K depth to 512K depth without extra logic.



INTERLEAVE READ TIMING (Refer to non-interleave write timing for interleave write timing)

(ADSP CONTROLLED, ADSC=HIGH)



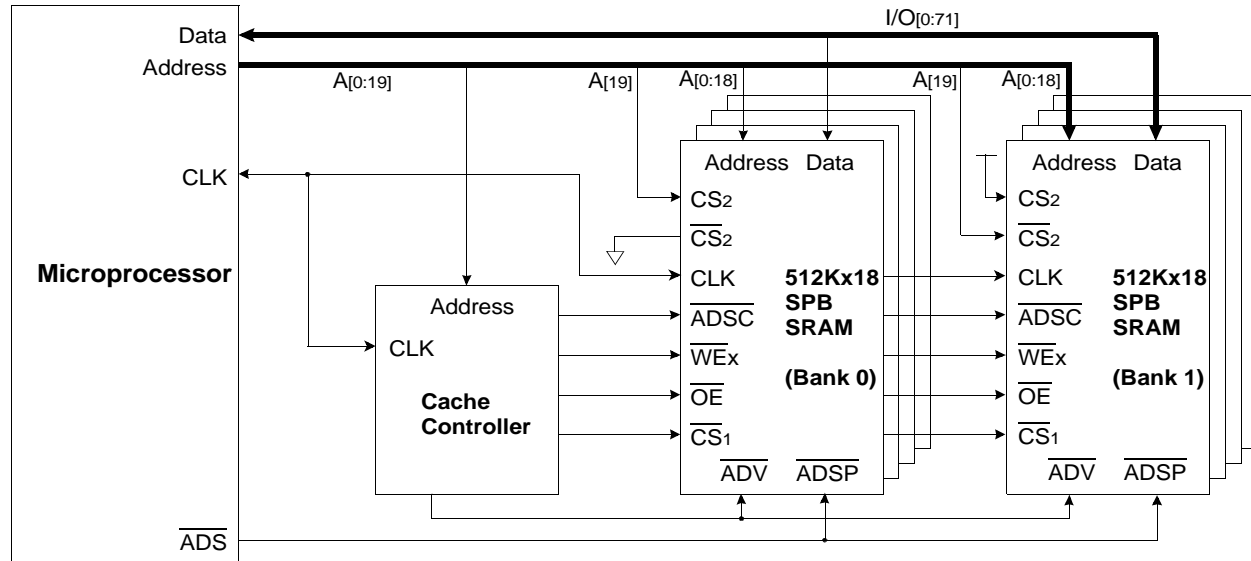
\*Notes : n = 14 32K depth, 15 64K depth  
16 128K depth, 17 256K depth  
18 512K depth

□ Don't Care    ⊗ Undefined

**APPLICATION INFORMATION**

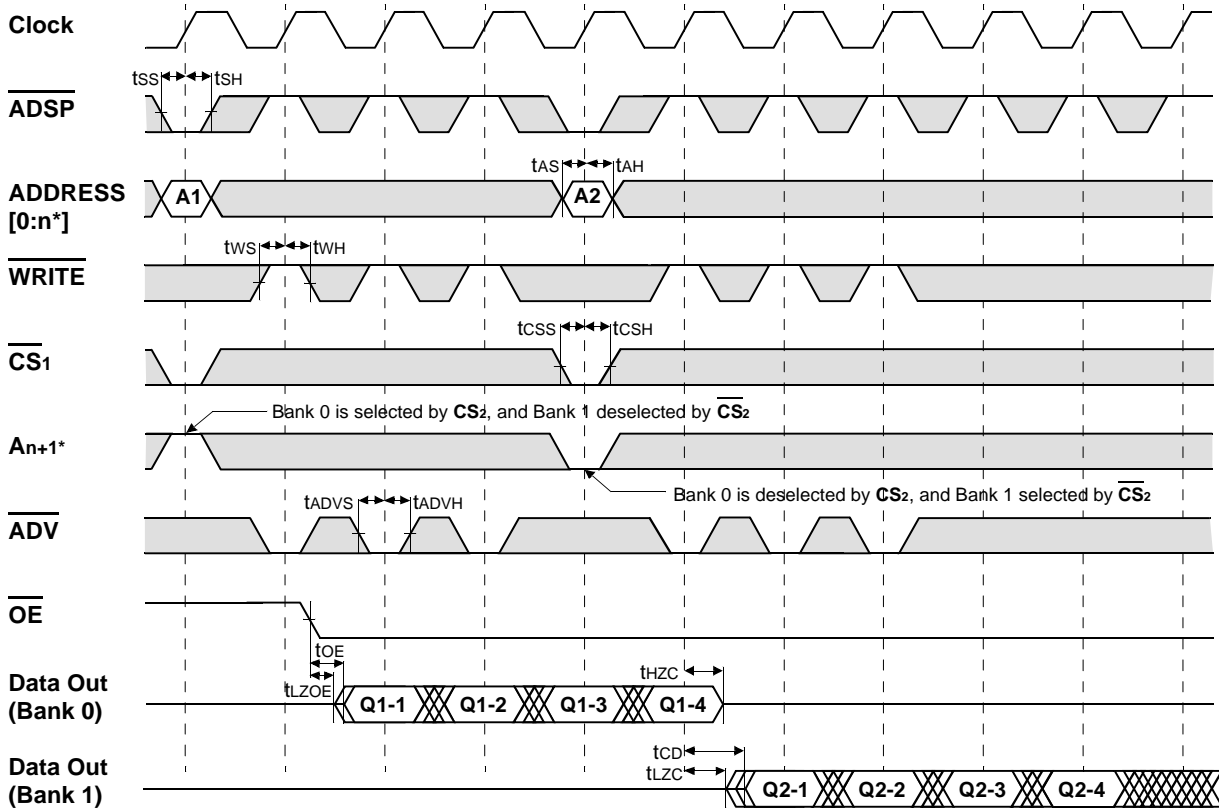
**DEPTH EXPANSION**

The Samsung 512Kx18 Synchronous Pipelined Burst SRAM has two additional chip selects for simple depth expansion. This permits easy secondary cache upgrades from 512K depth to 1M depth without extra logic.



**INTERLEAVE READ TIMING** (Refer to non-interleave write timing for interleave write timing)

**(ADSP CONTROLLED , ADSC=HIGH)**



\*Notes : n = 14 32K depth , 15 64K depth  
16 128K depth , 17 256K depth  
18 512K depth , 19 1M depth

□ Don't Care    ⊗ Undefined



PACKAGE DIMENSIONS

